

Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/716,033	LEE, JAE HOON
	Examiner	Art Unit
	Michael Leslie	3745

ISSUE CLASSIFICATION				
ORIGINAL			CROSS REFERENCE(S)	
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)	
91	445	91	448	
INTERNATIONAL CLASSIFICATION				
F	1	5	B	13/04
			/	
			/	
			/	
			/	
<i>Michael Leslie</i> 6/23/05 (Assistant Examiner) (Date)			<i>Edward K. Look</i> 6/27/05 EDWARD K. LOOK SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 3700 (Primary Examiner) (Date)	
<i>H Cooper</i> 6/29/05 (Legal Instruments Examiner) (Date)			Total Claims Allowed: 14 O.G. Print Claim(s) 1 O.G. Print Fig. 4	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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9	5	35	65	95	125	155	185
10	6	36	66	96	126	156	186
12	7	37	67	97	127	157	187
11	8	38	68	98	128	158	188
13	9	39	69	99	129	159	189
3	10	40	70	100	130	160	190
4	11	41	71	101	131	161	191
5	12	42	72	102	132	162	192
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	15	45	75	105	135	165	195
	16	46	76	106	136	166	196
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